

Preliminary

SIDC42D170E6

Fast switching diode chip in EMCON-Technology

FEATURES:

- 1700V EMCON technology 200 µm chip
- soft , fast switching
- low reverse recovery charge
- small temperature coefficient

This chip is used for:

EUPEC power modules and discrete devices

Applications:

SMPS, resonant applications, drives



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Chip Type	V _R	I _F	Die Size	Package	Ordering Code
SIDC42D170E6	1700V	50A	6.5 x 6.5 mm ²	sawn on foil	Q67050-A4119- A001

MECHANICAL PARAMETER:

6.5 x 6.5				
42.25 / 28.3	mm ²			
5.08 x 5.08				
200				
150				
180	deg			
340 pcs	340 pcs			
Photoimide				
3200 nm Al Si 1%				
1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
electrically conductive glue or solder				
Al, ≤500μm				
Ø 0.65mm				
store in original container, in dry nitrogen, < 6 month				
	42.25 / 28.3 5.08 x 5.08 200 150 180 340 pcs Photoimide 3200 nm Al Si 1% 1400 nm Ni Ag –system suitable for epoxy and soft solder did electrically conductive glue or s Al, ≤500μm Ø 0.65mm store in original container, in dry n			



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Maximum Ratings

Parameter	Symbol	Condition	Value	Unit
Repetitive peak reverse voltage	V_{RRM}		1700	V
Continuous forward current limited by T_{jmax}	I _F		50	
Single pulse forward current (depending on wire bond configuration)	I _{FSM}	$t_P = 10 \text{ ms sinusoidal}$	tbd	A
Maximum repetitive forward current limited by T _{jmax}	I _{FRM}		100	
Operating junction and storage temperature	$T_{\rm j}$, $T_{ m stg}$		-55+150	°C

$\textbf{Static Electrical Characteristics} \text{ (tested on chip), } \textit{T}_{j}\text{=}25~^{\circ}\text{C, unless otherwise specified}$

Parameter	Symbol	Condi	Value			Unit	
raiailletei	Syllibol	Conditions		min.	Тур.	max.	Onne
Reverse leakage current	I_{R}	V _R =1700V	$T_j=25$ °C			375	μA
Cathode-Anode breakdown Voltage	V _{Br}	$I_R=4mA$	$T_j=25$ °C	1700			V
Forward voltage drop	V_F	I _F =50A	$T_j=25$ °C		2.15		V

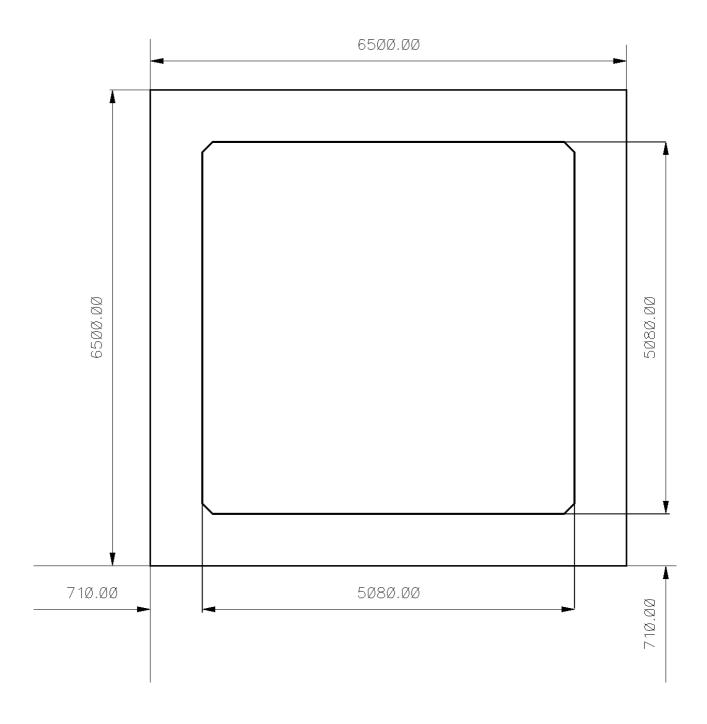
Dynamic Electrical Characteristics, at $T_j = 25$ °C, unless otherwise specified, tested at component

Daramatar	Cumbal	Candi	itiana	Value			I In it	
Parameter	Symbol	Conditions		min.	Тур.	max.	Unit	
Reverse recovery time	t _{rr1}	I _F =50A	$T_j = 25 ^{\circ}C$		tbd			
	t_{rr2}	$di/dt=750A/ms$ $V_R=900V$	$T_j = 150 ^{\circ}\mathrm{C}$				ns	
Peak recovery current	I _{RRM1}	I _F =50A	$T_j = 25 ^{\circ}C$		36			
	I _{RRM2}	$di/dt=750A/ms$ $V_R=900V$	$T_j = 150 ^{\circ}\text{C}$		56		A	
Reverse recovery charge	Q_{rr1}	I _F =50A	$T_j=25$ °C		6			
	Q _{rr2}	$di/dt=750A/ms$ $V_R=900V$	T _j =150°C		12		μC	
Peak rate of fall of reverse	di _{rr1} /dt	I _F =50A	$T_j=25^{\circ}C$		tbd			
recovery current	di _{rr2} /dt	$di/dt = 750A/ms$ $V_R = 900V$	T _j =150°C				A/μs	
Softness	S1	I _F =50A	$T_j=25$ °C		tbd		1	
	S2		T _j =150°C					



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CHIP DRAWING:





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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the	INFINEON TECHNOLOGIES /	tbd
device data sheet	EUPEC	tod

Description:

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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